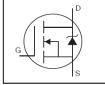
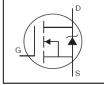
HEXFET® Power MOSFET



- Logic -Level Gate Drive
- Advanced Process Technology
- Isolated Package
- High Voltage Isolation = 2.5KVRMS ©
- Sink to Lead Creepage Dist. = 4.8mm
- Fully Avalanche Rated
- Lead-Free



$V_{ extsf{DSS}}$	100V
$R_{DS(on)}$	0.044Ω
I _D	23A



	Т		
G		D	S
Gate		Drain	Source

Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low onresistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The TO-220 Full Pak eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heat sink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The Fullpak is mounted to a heat sink using a single clip or by a single screw fixing.

Book Bort Number Bookers Type		Standar	Standard Pack		
Base Part Number	Package Type	Form	Quantity	Orderable Part Number	
IRLI540NPbF	TO-220 Full-Pak	Tube	50	IRLI540NPbF	

Absolute Maximum Ratings					
Symbol	Parameter	Max.	Units		
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	23			
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	16	Α		
l _{DM}	Pulsed Drain Current ①⑥	120			
P _D @T _C = 25°C	Maximum Power Dissipation	54	W		
	Linear Derating Factor	0.36	W/°C		
V_{GS}	Gate-to-Source Voltage	± 16	V		
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ②⑥	310	mJ		
AR	Avalanche Current ①⑥	18	Α		
E _{AR}	Repetitive Avalanche Energy ①	5.4	mJ		
dv/dt	Peak Diode Recovery dv/dt36	5.0	V/ns		
T_J	Operating Junction and	-55 to + 175			
T_{STG}	Storage Temperature Range		°C		
	Soldering Temperature, for 10 seconds (1.6mm from case)	300			
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)			

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-Case		2.8	°C/W
$R_{ heta JA}$	Junction-to-Ambient		65	C/VV

2017-04-27



Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	100			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.11			Reference to 25°C, I _D = 1mA ©
, ,				0.044		V _{GS} = 10V, I _D = 12A
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.053	Ω	V _{GS} = 5.0V, I _D = 12A
_ = = = = = = = = = = = = = = = = = = =				0.063		V _{GS} = 4.0V, I _D = 10A
$V_{GS(th)}$	Gate Threshold Voltage	1.0		2.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
gfs	Forward Trans conductance	14				V _{DS} = 25V, I _D = 18A®
1	Drain to Course Leakage Current			25		$V_{DS} = 100V, V_{GS} = 0V$
I _{DSS}	Drain-to-Source Leakage Current			250	μA	$V_{DS} = 80V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
1	Gate-to-Source Forward Leakage			100	nA	V _{GS} = 16V
I _{GSS}	Gate-to-Source Reverse Leakage			-100	IIA	$V_{GS} = -16V$
Q_g	Total Gate Charge			74		I _D = 18A
Q_gs	Gate-to-Source Charge			9.4	nC	V _{DS} = 80V
Q_{gd}	Gate-to-Drain Charge			38		V _{GS} = 5.0V , See Fig. 6 and 13④⑥
$t_{d(on)}$	Turn-On Delay Time		11			$V_{DD} = 50V$
t _r	Rise Time		81		200	I _D = 18A
t _{d(off)}	Turn-Off Delay Time		39		ns	R_{G} = 5.0 Ω , V_{GS} = 5.0 V
t _f	Fall Time		62			R _D = 2.7Ω, See Fig. 10④⑥
L_D	Internal Drain Inductance		4.5			Between lead, 6mm (0.25in.)
Ls	Internal Source Inductance		7.5			from package and center of die contact
C _{iss}	Input Capacitance		1800			V _{GS} = 0V
C _{oss}	Output Capacitance		350		م ا	V _{DS} = 25V
C _{rss}	Reverse Transfer Capacitance		170		pF	f = 1.0MHz, See Fig. 5⊚
С	Drain to Sink Capacitance		12			f = 1.0MHz

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current (Body Diode)			23		MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ①⑥			120	- A	integral reverse p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 18A, V_{GS} = 0V $ ④
t _{rr}	Reverse Recovery Time		190	290	ns	T _J = 25°C ,I _F = 18A
Q _{rr}	Reverse Recovery Charge		1.1	1.7	μС	di/dt = 100A/µs ⊕᠖
t _{on}	Forward Turn-On Time	Intrinsio	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)			

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Starting $T_J = 25$ °C, L = 1.9mH, $R_G = 25\Omega$, $I_{AS} = 18$ A (See fig. 12)
- $\label{eq:local_state} \mbox{ } \mbo$
- ⑤ t=60s, f=60Hz
- © Uses IRL540N data and test conditions.



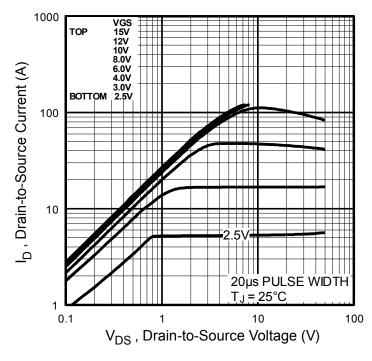


Fig. 1 Typical Output Characteristics

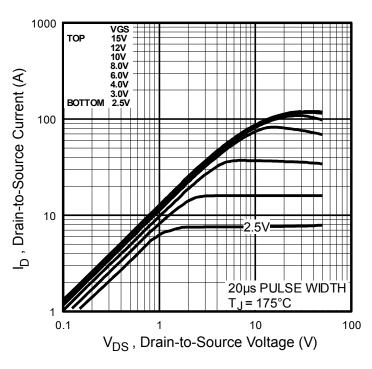


Fig. 2 Typical Output Characteristics

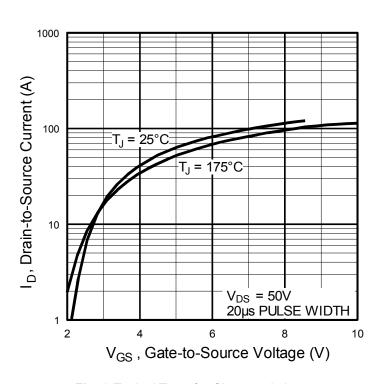


Fig. 3 Typical Transfer Characteristics

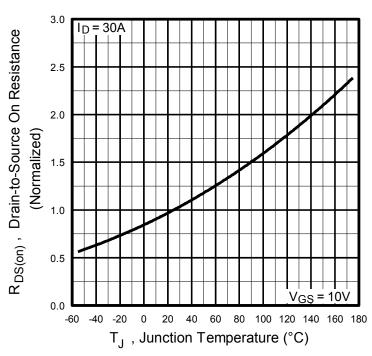


Fig. 4 Normalized On-Resistance vs. Temperature

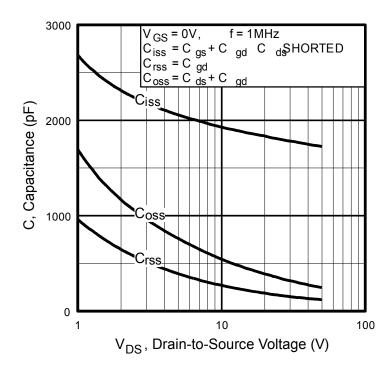


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

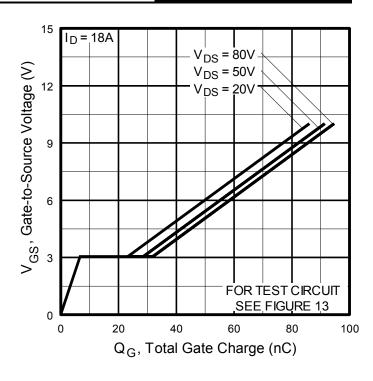


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

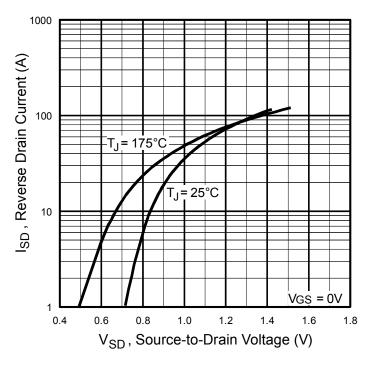


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

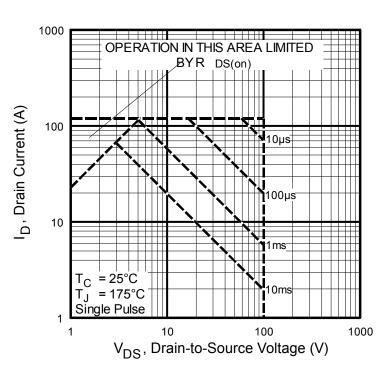


Fig 8. Maximum Safe Operating Area

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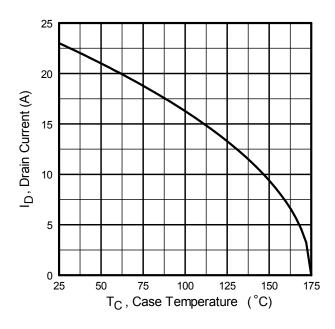


Fig 9. Maximum Drain Current vs. Case Temperature

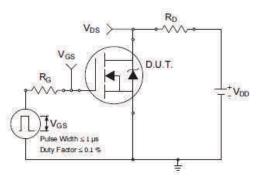


Fig 10a. Switching Time Test Circuit

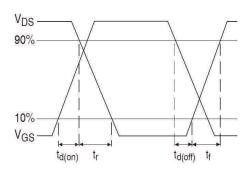


Fig 10b. Switching Time Waveforms

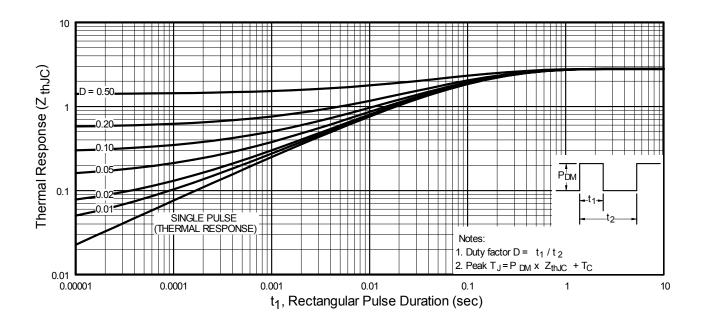


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



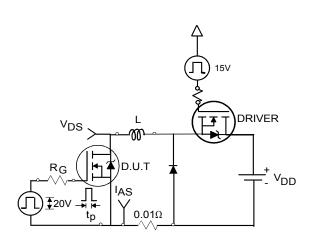


Fig 12a. Unclamped Inductive Test Circuit

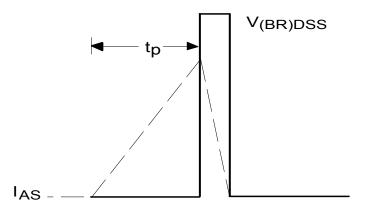


Fig 12b. Unclamped Inductive Waveforms

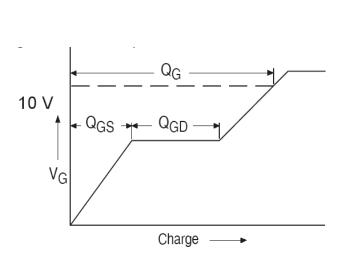


Fig 13a. Gate Charge Waveform

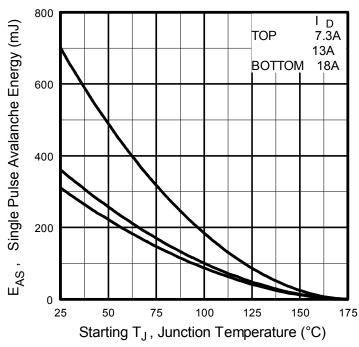


Fig 12c. Maximum Avalanche Energy vs. Drain Current

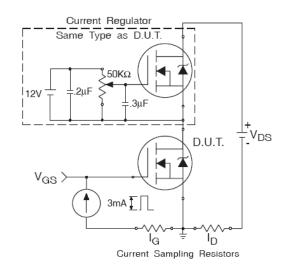
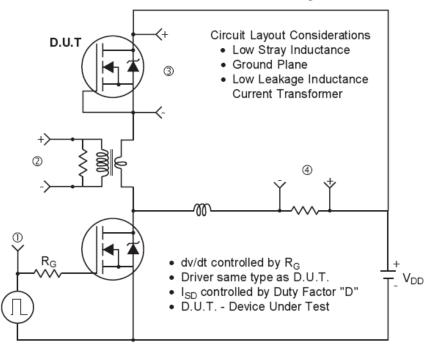


Fig 13b. Gate Charge Test Circuit

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Peak Diode Recovery dv/dt Test Circuit



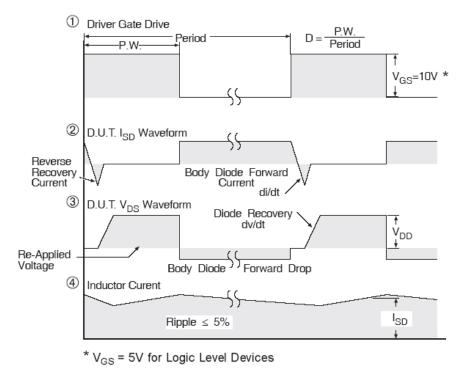
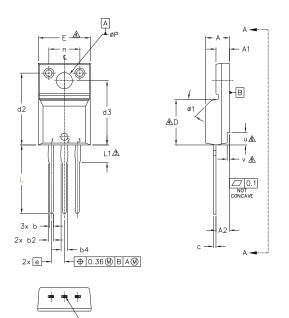
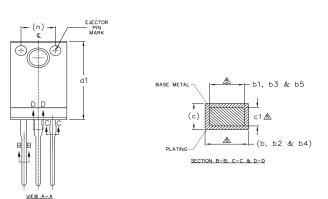


Fig 14. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs



TO-220 Full-Pak Package Outline (Dimensions are shown in millimeters (inches))





NOTES:

1.0 DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994.

2,0 DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

(3,0) LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.

DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTER MOST EXTREMES OF THE PLASTIC BODY.

DIMENSION 61, 63, 65 & c1 APPLY TO BASE METAL ONLY.

 $\cancel{6}. \overleftarrow{\Delta}$ step optional on plastic body defined by dimensions u & v.

7.0 CONTROLLING DIMENSION: INCHES.

S Y	DIMENSIONS				
М	DIMENSIONS				N
В	MILLIM	ETERS	INC	NOTES	
0 L	MIN.	MAX.	MIN.	MAX.	S
Α	4.57	4.83	.180	.190	
Α1	2.57	2.82	.101	.111	
Α2	2.51	2.92	.099	.115	
Ь	0.61	0.94	.024	.037	
b1	0.61	0.89	.024	.035	5
b2	0.76	1.27	.030	.050	
ь3	0.76	1.22	.030	.048	5
Ь4	1.02	1.52	.040	.060	
b5	1.02	1.47	.040	.058	5
С	0.33	0.63	.013	.025	
c1	0.33	0.58	.013	.023	5
D	8.66	9.80	.341	.386	4
d1	15.80	16.13	.622	.635	
d2	13.97	14.22	.550	.560	
d3	12.29	12.93	.484	.509	
E	9.63	10.74	.379	.423	4
е		BSC		BSC	
L	13.21	13.72	.520	.540	
L1	3.10	3.68	.122	.145	3
n	6.05	6.60	.238	.260	
ØΡ	3.05	3.45	.120	.136	
u	2.39	2.49	.094	.098	6
٧	0.41	0.51	.016	.020	6
Ø1	_	45°	_	45°	

LEAD ASSIGNMENTS

<u>HEXFET</u>

1.- GATE

2.- DRAIN

3.- SOURCE

IGBTs, CoPACK

1.- GATE

2.- COLLECTOR

3.- EMITTER

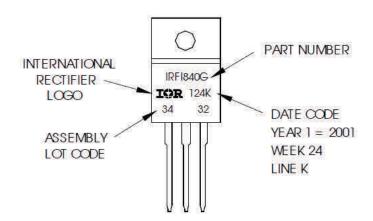
TO-220 Full-Pak Part Marking Information

EXAMPLE: THIS IS AN IRF1840G WITH ASSEMBLY

LOT CODE 3432

ASSEMBLED ON WW 24, 2001 IN THE ASSEMBLY LINE "K"

Note: "P" in assembly line position indicates "Lead-Free"



TO-220AB Full-Pak packages are not recommended for Surface Mount Application.

Note: For the most current drawing please refer to website at http://www.irf.com/package/



Qualification Information

<u>Quamitation</u>				
Qualification Level	Industrial (per JEDEC JESD47F) †			
Moisture Sensitivity Level	TO-220 Full-Pak N/A			
RoHS Compliant	Yes			

† Applicable version of JEDEC standard at the time of product release.

Revision History

Date	Comments
	Changed datasheet with Infineon logo - all pages.
04/27/2017	Corrected Package Outline on page 8.
	Added disclaimer on last page.

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